Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/796,011	TAKE, KEIJIRO
Examiner	Art Unit
Tri H. Phan	2661

	SEARCHED				
Class	Subclass	Date	Examiner		
370	320,335, 342,441, 479,203	12/6/2004	TP		
370	350,332	12/6/2004	TP		
370	508-510	12/6/2004	TP		
375	200	12/6/2004	TP		
Updated	search	6/17/2005	TP		
Updated	search	1/21/2006	TP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, IEEE,Internet search	12/6/2004	TP		
Consulted with Brian Nguyen (Pri)	6/16/2005	TP		
Inventorship search	1/21/2006	TP		